

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,
Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

IECQ Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 19.0009 Issue No.: 4 Status: Current

Supersedes: IECQ-L ULTW 19.0009 Issue 3 Issue Date: 2022/12/18 Org Issue: 2019/12/24

CB Reference No.: 50600264 ITL **Expiration: 2025/12/23**

ATP Electronics Taiwan Inc. Reliability Testing Laboratory

No. 16-2, Neihuan S. Rd. Nanzih Technology Industrial Park Kaohsiung City 811 Taiwan

The organization, facilities and procedures have been assessed and found to comply with the applicable requirements for Independent Testing Laboratory organization approval, in support of the IECQ system, which is in accordance with the Basic Rules IECQ 01 and Rules of Procedure IECQ 03-6 "Independent Testing Laboratory Assessment Program Requirements" of the IEC Quality Assessment System for Electronic Components (IECQ) and applicable requirements of ISO/IEC 17025:2017 for the testing of electronic components under the IECQ.

Scope:

Reliability testing for memory and storage products.

See attached schedule.

-- Attached Schedule: IECQ-L_ULTW_50600264 ITL. Schedule 12-18-22.pdf --

Approved by Certification Body (CB): DQS Group - DQS Taiwan Inc.

8th Fl., 23, Yuan Huan West Road, Feng Yuan Dist., Taichung City

Taiwan

Authorized person:

Rock Chang





The validity of this certificate is maintained through on-going surveillance audits by the IECQ CB issuing this certificate.

This Certificate of Conformity may be suspended or withdrawn in accordance with the

Rules of Procedure of the IECQ System and its Schemes.

This certificate and any schedule(s) may only be reproduced in full.

This certificate is not transferable and remains the property of the issuing IECQ CB.

The Status and authenticity of this certificate may be verified by visiting $\underline{\text{www.iecq.org}}$



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Schedule of Scope to Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 19.0009
CB Certificate No.: 50600264 ITL

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Appendix-1 (50600264 ITL) Schedule of Scope to Certificate of Approval

Test Items	Standard/Method
Drop Test	ISTA 1,2A (ATP-03-10-0089)
High Temperature Operation Test	JESD22-A108 (ATP-03-10-0090)
High Temperature Storage Test	JESD22-A103 (ATP-03-10-0090)
Low Temperature Operation Test	JESD22-A108 (ATP-03-10-0095)
Low Temperature Storage Test	JESD22-A119 (ATP-03-10-0095)
Temperature and Humidity Test	IEC60068-2-78 (ATP-03-10-0099)
Temperature Cycling Test	JESD22-A104 (ATP-03-10-0098)

Technical Reviewer of DQS:_

_Date: 12/18/2022



Tue Voz